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March 1998

FDN357N N-Channel Logic Level Enhancement Mode Field Effect Transistor

General Description

SuperSOTTM-3 N-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications in notebook computers, portable phones, PCMCIA cards, and other battery powered circuits where fast switching, and low in-line power loss are needed in a very small outline surface mount package.

Features

- 1.9 A, 30 V, $R_{DS(ON)} = 0.090 \ \Omega \ @ V_{GS} = 4.5 \ V$ $R_{DS(ON)} = 0.060 \ \Omega \ @ V_{GS} = 10 \ V.$
- Industry standard outline SOT-23 surface mount package using proprietary SuperSOT[™]-3 design for superior thermal and electrical capabilities.
- High density cell design for extremely low R_{DS(ON)}.
- Exceptional on-resistance and maximum DC current capability.

so	OT-23	SuperSOT [™] -6	SuperSOT [™] -8	SO-8	SOT-223	SOIC-16
		D 351	s			
	-	_{SOT[™]3} G			G	
Absol Symbol	-	_{SOT[™]3} G	= 25°C unless other wise not	ied	G S	Units
Symbol	ute Maximu	$\mathbf{SOT}^{T}_{3} \mathbf{G}$		ed		
Symbol / DSS	ute Maximu Parameter Drain-Source	$\mathbf{SOT}^{T}_{3} \mathbf{G}$	= 25°C unless other wise not	ed	FDN357N	Units
	ute Maximu Parameter Drain-Source Gate-Source	SOT [™] 3 G Im Ratings T _A =	= 25°C unless other wise not	ed	FDN357N 30	Units
bymbol DSS GSS	ute Maximu Parameter Drain-Source Gate-Source	SOT [™] -3 G Im Ratings T _A = e Voltage Voltage - Continuous	= 25°C unless other wise not	ied	FDN357N 30 ±20	Units V V V
Symbol DSS GSS	ute Maximu Parameter Drain-Source Gate-Source Drain/Output	SOT [™] -3 G m Ratings T _A = Poltage Voltage - Continuous Current - Continuous	= 25°C unless other wise not	ied	FDN357N 30 ±20 1.9	Units V V
Cymbol DSS GSS	ute Maximu Parameter Drain-Source Gate-Source Drain/Output	SOT [™] -3 G MR Ratings T _A = 2 Voltage Voltage - Continuous Current - Continuou - Pulsed	= 25°C unless other wise not s	ed	FDN357N 30 ±20 1.9 10	Units V V A
ymbol DSS GSS D	ute Maximu Parameter Drain-Source Gate-Source Drain/Output Maximum Po	SOT [™] -3 G MR Ratings T _A = 2 Voltage Voltage - Continuous Current - Continuou - Pulsed	= 25°C unless other wise not S S (Note 1a) (Note 1b)	ied	FDN357N 30 ±20 1.9 10 0.5	Units V V A
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Coss Coss Coss Coss Co Co Co Co Co Co Co Co Co Co Co Co Co	Ute Maximu Parameter Drain-Source Gate-Source Drain/Output Maximum Po Operating ar AL CHARACTE	SOT [™] -3 G Im Ratings T _A = Poltage Voltage - Continuous Current - Continuous - Pulsed wer Dissipation d Storage Temperatu	= 25°C unless other wise not s s (Note 1a) (Note 1b) ure Range		FDN357N 30 ±20 1.9 10 0.5 0.46	Units V V V A W W

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Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHAR	ACTERISTICS					•
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	I_{D} = 250 µA, Referenced to 25 °C		36		mV/ °C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{\rm DS} = 24 \text{V}, \text{V}_{\rm GS} = 0 \text{V}$			1	μA
		$T_{J} = 55^{\circ}C$;		10	μA
I _{GSSF}	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR}	Gate - Body Leakage, Reverse	$V_{gs} = -20 \text{ V}, \text{ V}_{Ds} = 0 \text{ V}$			-100	nA
ON CHARA	CTERISTICS (Note)					
V _{GS(th)}	Gate Threshold Voltage	$V_{\rm DS} = V_{\rm GS}, \ I_{\rm D} = 250 \ \mu {\rm A}$	1	1.6	2	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Temp. Coefficient	I_{D} = 250 µA, Referenced to 25 °C		-3.6		mV/ °C
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_{D} = 1.9 \text{ A}$		0.081	0.09	Ω
		T _J =125°	C	0.11	0.14	
		$V_{GS} = 10 \text{ V}, I_{D} = 2.2 \text{ A}$		0.053	0.06	
I _{D(ON)}	On-State Drain Current	$V_{GS} = 4.5 V, V_{DS} = 5 V$	5			Α
9 _{FS}	Forward Transconductance	$V_{DS} = 5 V, I_{D} = 1.9 A$		5		S
DYNAMIC (CHARACTERISTICS					
C _{iss}	Input Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		235		pF
C _{oss}	Output Capacitance			145		pF
C _{rss}	Reverse Transfer Capacitance			50		pF
SWITCHING	CHARACTERISTICS (Note)					
t _{D(on)}	Turn - On Delay Time	$V_{DD} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		5	10	ns
t,	Turn - On Rise Time			12	22	ns
t _{D(off)}	Turn - Off Delay Time			12	22	ns
t,	Turn - Off Fall Time			3	8	ns
Q _g	Total Gate Charge	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1.9 \text{ A},$ $V_{GS} = 5 \text{ V}$		4.2	5.9	nC
Q _{gs}	Gate-Source Charge			1.3		nC
Q_{gd}	Gate-Drain Charge			1.7		nC
DRAIN-SO	JRCE DIODE CHARACTERISTICS AND M	AXIMUM RATINGS		T		
l _s	Maximum Continuous Drain-Source Diode For	rward Current			0.42	Α
V _{SD}	Drain-Source Diode Forward Voltage	Forward Voltage $V_{GS} = 0 \text{ V}, I_{S} = 0.42 \text{ A} (Note)$		0.71	1.2	V

1. R_{BM} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BUC} is guaranteed by design while R_{BCA} is determined by the user's board design.

Typical $R_{_{\theta,h}}$ using the board layouts shown below on 4.5"x5" FR-4 PCB in a still air environment :

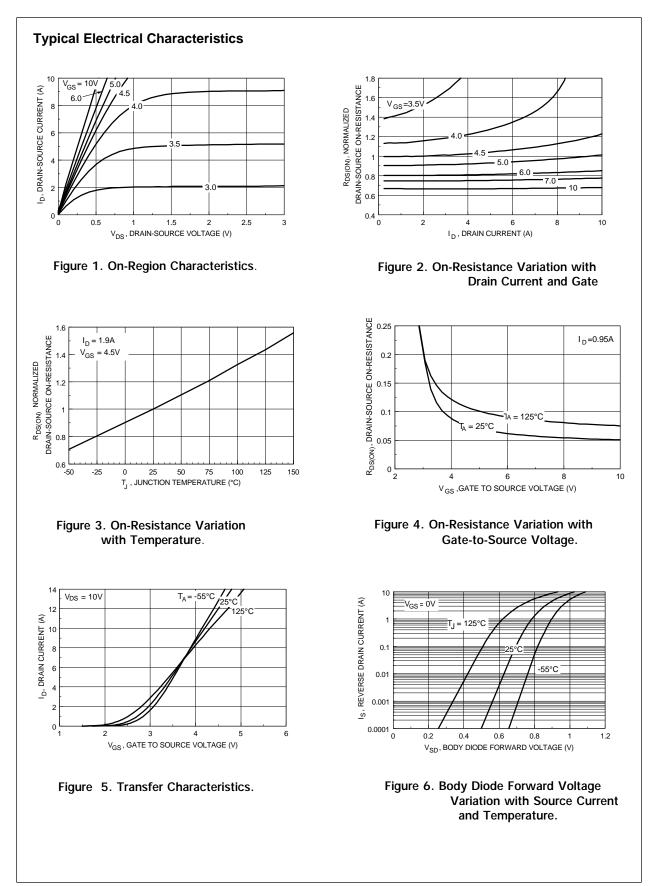


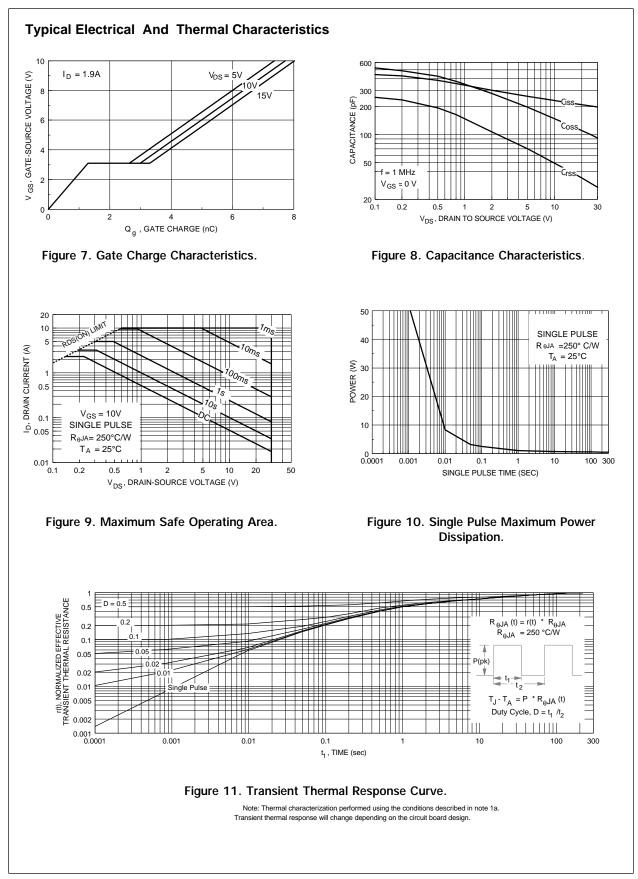
1 75

a. 250°C/W when mounted on a 0.02 in² pad of 2oz Cu. b. 270°C/W when mounted on a 0.001 in² pad of 2oz Cu.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2.0%.





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Телефон: 8 (812) 309 58 32 (многоканальный) **Факс:** 8 (812) 320-02-42 **Электронная почта:** <u>org@eplast1.ru</u> **Адрес:** 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.